

STX83003

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- ST83003 SILICON IN TO-92 PACKAGE
- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

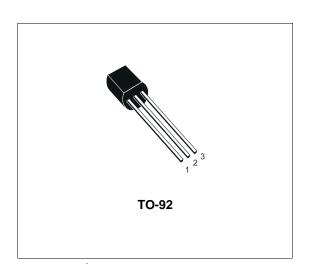
APPLICATIONS:

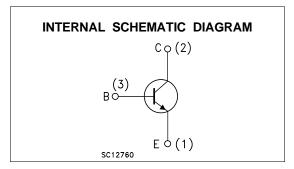
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

DESCRIPTION

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and medium voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The STX83003 is expressly designed for a new solution to be used in compact fluorescent lamps, where it is coupled with the STX93003, its complementary PNP transistor.





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|------------------|-------------------------------------------------------------------------------------|---------------|------|
| Vces | Collector-Emitter Voltage (V _{BE} = 0) | 700 | V |
| V_{CEO} | Collector-Emitter Voltage (I _B = 0) | 400 | V |
| V _{EBO} | Emitter-Base Voltage ($I_C = 0$, $I_B = 0.5$ A, $t_p < 10\mu s$, $T_j < 150$ °C) | $V_{(BR)EBO}$ | V |
| Ic | Collector Current | 1 | A |
| I _{CM} | Collector Peak Current (t _p < 5 ms) | 3 | Α |
| lΒ | Base Current | 0.5 | Α |
| I _{BM} | Base Peak Current (t _p < 5 ms) | 1.5 | Α |
| P _{tot} | Total Dissipation at T _C = 25 °C | 1.5 | W |
| T _{stg} | Storage Temperature | -65 to 150 | °C |
| Tj | Max. Operating Junction Temperature | 150 | °C |

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THERMAL DATA

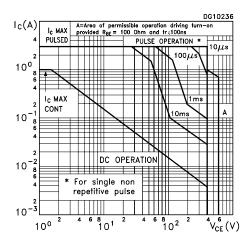
| R _{thj-case} | Thermal Resistance Junction-Case | Max | 83.3 | °C/W |
|-----------------------|-------------------------------------|-----|------|------|
| R _{thj-amb} | Thermal Resistance Junction-Ambient | Max | 200 | °C/W |

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

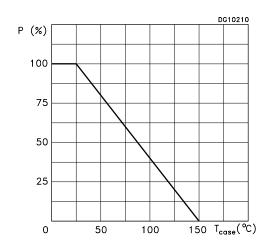
| Symbol | Parameter | Test Conditions | | Min. | Тур. | Max. | Unit |
|-------------------------|-----------------------------------------------------------------|------------------------------------------------------------------------------------|-------------------------------------------------|---------------|-------------------|----------|----------------|
| I _{CES} | Collector Cut-off Current (V _{BE} = 0) | V _{CE} = 700V V _{CE} = 700V | $T_j = 125^{\circ}C$ | | | 1 5 | mA mA |
| V _{(BR)EBO} | Emitter-Base Breakdown Voltage (I _C = 0) | I _E = 10 mA | | 12 | | 18 | V |
| V _{CEO(sus)} * | Collector-Emitter Sustaining Voltage (I _B = 0) | I _C = 10 mA L = 25 mH | | 400 | | | V |
| V _{CE(sat)*} | Collector-Emitter Saturation Voltage | $I_C = 0.5 A$ $I_C = 0.35 A$ | $I_B = 0.1 A$ $I_B = 50 mA$ | | | 0.5 1 | V V |
| V _{BE(sat)} * | Base-Emitter Saturation Voltage | I _C = 0.5 A | I _B = 0.1 A | | | 1 | V |
| h _{FE} * | DC Current Gain | $I_C = 10 \text{ mA}$ $I_C = 0.35 \text{ A}$ $I_C = 1 \text{ A}$ | $V_{CE} = 5 V$ $V_{CE} = 5 V$ $V_{CE} = 5 V$ | 10 16 4 | 25 | 32 | |
| tr ts tf | RESISTIVE LOAD Rise Time Storage Time Fall Time | $I_{C} = 0.35 \text{ A}$ $I_{B1} = 70 \text{ mA}$ $T_{p} \ge 25 \mu\text{s}$ | $Vcc = 125 V$ $I_{B2} = -70 mA$ (see figure 2) | 1.5 | 100 2.2 0.2 | 2.9 | ns µs µs |
| t _s | INDUCTIVE LOAD Storage Time Fall Time | $I_{C} = 0.5 \text{ A}$ $V_{BE(off)} = -5 \text{ V}$ $V_{clamp} = 300 \text{ V}$ | $I_{B1} = 0.1 A$ L = 10 mH (see figure 1) | | 450 90 | | ns ns |

^{*} Pulsed: Pulse duration = 300μs, duty cycle = 1.5 %.

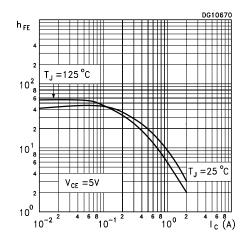
Safe Operating Area



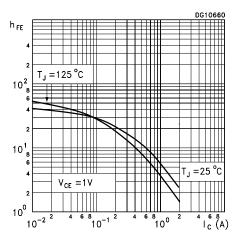
Derating Curve



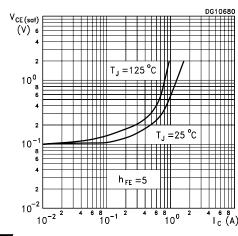
DC Current Gain



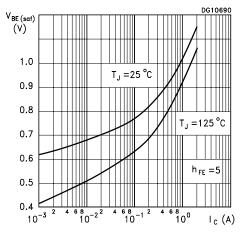
DC Current Gain



Collector Emitter Saturation Voltage



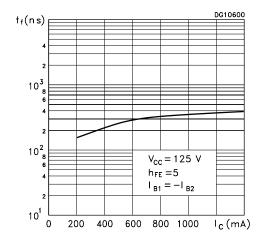
Base Emitter Saturation Voltage



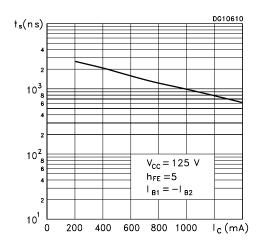
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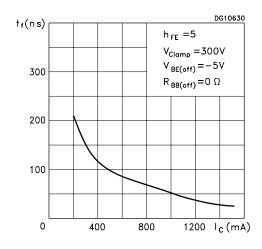
Resistive Load Fall Time



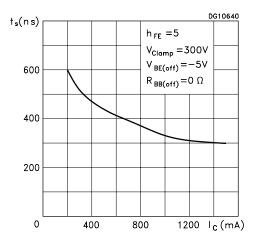
Resistive Load Storage Time



Inductive Load Fall Time



Inductive Load Storage Time



Reverse Biased SOA

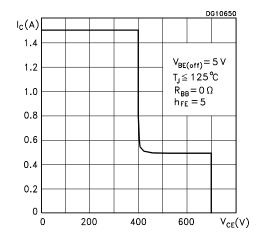


Figure 1: Inductive Load Switching Test Circuit.

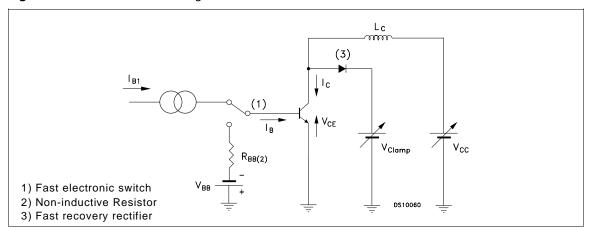
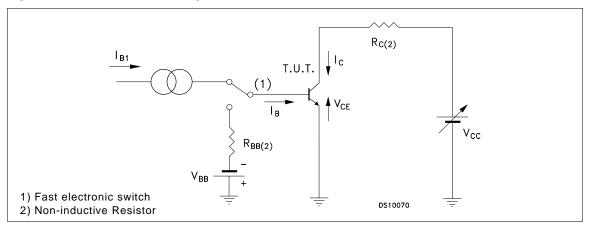
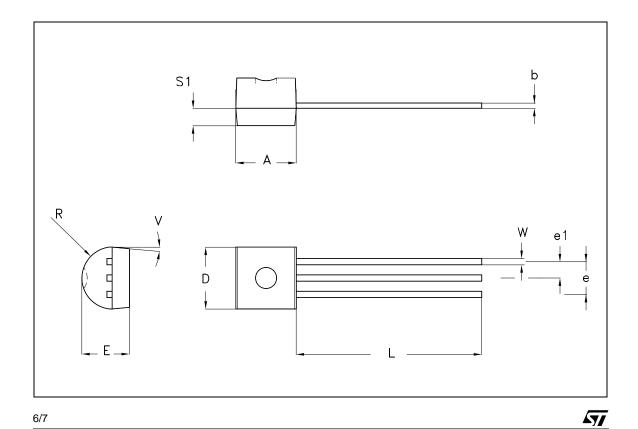


Figure 2: Resistive Load Switching Test Circuit.



TO-92 MECHANICAL DATA

| DIM. | | mm | | | inch | |
|------|----------|------|----------|----------|------|----------|
| Dim. | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 4.32 | | 4.95 | 0.170 | | 0.195 |
| b | 0.36 | | 0.51 | 0.014 | | 0.020 |
| D | 4.45 | | 4.95 | 0.175 | | 0.194 |
| Е | 3.30 | | 3.94 | 0.130 | | 0.155 |
| е | 2.41 | | 2.67 | 0.095 | | 0.105 |
| e1 | 1.14 | | 1.40 | 0.045 | | 0.055 |
| L | 12.70 | | 15.49 | 0.500 | | 0.609 |
| R | 2.16 | | 2.41 | 0.085 | | 0.094 |
| S1 | 1.14 | | 1.52 | 0.045 | | 0.059 |
| W | 0.41 | | 0.56 | 0.016 | | 0.022 |
| V | 4 degree | | 6 degree | 4 degree | | 6 degree |



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